

<b>Notice of References Cited</b>	Application/Control No. 10/527,234		Applicant(s)/Patent Under Reexamination HASEGAWA ET AL.	
	Examiner JONATHAN LEWIS		Art Unit 2425	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0000962 A1	05-2001	Rajan, Ganesh	345/302
*	B	US-2001/0013130 A1	08-2001	Shimizu et al.	725/91
*	C	US-2001/0052133 A1	12-2001	Pack et al.	725/109
*	D	US-6,519,771 B1	02-2003	Zenith, Steven Ericsson	725/32
*	E	US-6,564,383 B1	05-2003	Combs et al.	725/136
*	F	US-7,028,324 B2	04-2006	Shimizu et al.	725/32
*	G	US-2006/0130109 A1	06-2006	Zenith, Steven Ericsson	725/110
*	H	US-2007/0124795 A1	05-2007	McKissick et al.	725/135
*	I	US-7,219,363 B2	05-2007	Yamato et al.	725/58
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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